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Conductance Quantisation in patterned gate In_{0.75}Ga_{0.25}As structures up to 6×(2e²/h)

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Abstract

We present electrical measurements from $In_{0.75}Ga_{0.25}As$ 1-dimensional channel devices with Rashba-type, spin-orbit coupling present in the 2-dimensional contact regions. Suppressed backscattering as a result of the time-reversal asymmetry at the 1dimensional channel entrance results in enhanced ballistic transport characteristics with clear quantised conductance plateaus up to $6\times(2e^2/h)$. Applying D.C. voltages between the source and drain ohmic contacts and an in-plane magnetic field confirms a ballistic transport picture. For asymmetric patterned gate biasing, a lateral spin-orbit coupling effect is weak. However, the Rashba-type spin-orbit coupling leads to a g-factor in the 1dimensional channel that is reduced in magnitude from the 2-dimensional value of 9 to ~ 6.5 in the lowest subband when the effective Rashba field and the applied magnetic field are perpendicular.

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1. Introduction

The limitations of conventional electronic devices can be overcome by implementing spin-based electronics where the spin degree of freedom plays the central role [1]. Ballistic transport in semiconductor nanowires is essential for applications in quantum logic devices [2] and utilising electron spin to encode logical information also paves the way for quantum computing [3]. However, many challenges must be overcome, such as injection, manipulation and detection of spin-polarised currents. For this to be achieved, materials with high spin-orbit coupling are being investigated as this is a possible mechanism for spin control without ferromagnetic contacts or large applied magnetic fields. Rashba-type spin-orbit coupling [4-6] could achieve electrical spin control and generation of spin-polarised current without the use of ferromagnetic contacts [7]. The Rashba spin-orbit coupling effect arises when an electron moves (with in plane wave vector components k_x , k_y) in an asymmetric potential at a heterojunction interface with

Rashba coefficient (α). An effective magnetic field exists, $B_R = \frac{2\alpha(k_y, -k_x, 0)}{g^* \mu_B}$ where

 μ_B is the Bohr Magneton and g* is the effective g-factor. This effective field lies in the plane of the 2-dimensional electron gas (2DEG) and is perpendicular to k. The precession of the electron spin can be modulated by adjusting the gate voltage to tune the confinement potential and hence α associated with the heterojunction. In_xGa_{1-x}As-based materials are ideal to study spin effects as the band structure is dominated by Rashba spin-orbit coupling induced by structural inversion asymmetry (SIA) at zero magnetic field [8]. The low electron effective mass (m*) of 0.040 m_e (m_e is the free electron mass, see reference [9]) in In_{0.75}Ga_{0.25}As also results in high electron mobilities and large 1-dimensional subband energy spacing. These characteristics make this material system a promising candidate for ballistic spintronics devices in 1-dimension.

Patterned gate devices that define a quantum wire in the 2DEG system are an effective way to study 1-dimensional transport, from a picture of non-interacting states [10, 11] to many body effects driven by electron-electron interaction [12]. Conductance quantisation has been demonstrated in high mobility GaAs devices, yet the small effective g-factor (|g*|=0.44) and weak spin-orbit coupling make it difficult to observe spin-polarisation

K

phenomena without the application of an external magnetic field. The g-factor for In_xGa_{1-x} . As devices with x > 0.5 is $|g^*| \sim 8$ and for the case of $In_{0.75}Ga_{0.25}As |g^*| = 9.1 \pm 0.1$ [13]. A summary of the initial spin transport measurements on undoped $In_{0.75}Ga_{0.25}As$ quantum wells and 1-dimensional channels were published in reference [14].

The outline of this article is as follows. The methods of fabricating and measuring the devices are described in Section 2. We then introduce the device characterisation and properties of 1-dimensional conductance in Section 3. We measure the device conductance when a D.C. voltage is applied to the source and the drain ohmic contacts and outline the method of obtaining an effective g factor in Section 3 C. In Section 4 the experimental data is summarised.

2. Methods

Standard Hall bars were processed from modulation doped, high electron mobility transistor (HEMT) structures. Au-Ge-Ni ohmic contacts were deposited using thermal evaporation and annealed at 450 °C for 120 s. The patterned gates were fabricated using electron beam lithography with Ti/Au metallisation. The device had a mobility of 2.9×10^5 $cm^2/V.s$ (at a carrier density of $2.3 \times 10^{11} cm^{-2}$) in the dark and $4.3 \times 10^5 cm^2/V.s$ (at 3.7×10¹¹ cm⁻²) after brief in-situ illumination at 4.2 K. Studies on modelling [15] the mobilities in the In_{0.75}Ga_{0.25}As wafers used in this work have taken into account four different scattering mechanisms, background impurities, remote (modulated doped) impurity, alloy disorder and interface roughness scattering. It was found that alloy disorder becomes more important as the carrier density increases before the on-set of intersubband scattering at carrier density of > 3.7×10^{11} cm⁻². The patterned gates have a length (L) of 200 nm and a width (W) of 400 nm. The gates are insulated from the In_{0.75}Al_{0.25}As barrier with 50 nm of SiO₂ dielectric. This is required as there is no Schottky barrier between metal gates deposited on the surface and the 2DEG [16]. The patterned gate devices were measured in a dilution fridge with a base temperature of 50 mK. Figure 1 shows the conductance on cooling from 4.2 K to 50 mK as the patterned gate voltage is swept to 0 V from depletion. An A.C. voltage of 100 μ V was applied between the source and the drain during cool down. The device was briefly illuminated at

4.2 K in order to get a conductance (G) of 1000 μ S. This corresponds to an electron density of 3.7×10^{11} cm⁻².

3. Experimental results and discussion

A. Device initialisation

In order to observe ballistic conductance quantisation the width of the channel must be comparable to the Fermi wavelength and the temperature must be low compared to the characteristic energy spacing of the 1-dimensional subbands in the channel. The electron mean free path (λ) which is 2.3 µm at 2.3×10¹¹ cm⁻² must be >> L, the channel length. Background impurities can lead to scattering in the channel and quasi-ballistic transport. In previous work [17] telegraph noise was identified as causing the conductance to vary by steps of ~ e²/h in etched InAs quantum point contacts with a low mobility of 65×10³ cm²/V.s. The background impurity density in the wafer studied here is ~ 5.6×10¹⁵ cm⁻³ [15] which results in an average impurity spacing of ~ 60 nm and narrow patterned gate separations are needed to avoid the effects of quasi-ballistic transport. The effective potential profile of the 1-dimensional channel was shown to vary based on a study of 256 lithographically identical split-gates [18].

The strong spin-orbit coupling in these systems suppresses backscattering due to the weak anti-localisation effect [19] leading to enhanced conductivity and clear ballistic transport. This is demonstrated experimentally here where we observe quantised conductance up to $6\times G_0$ ($G_0 = 2e^2/h$) see figure 1. A series resistance corresponding to the channel resistance at patterned gate voltage (V_{sg}) = 0 V, is removed to calculate the ballistic conductance of the channel. The conductance in figure 1 also shows a $0.7\times G_0$ structure which is widely accepted to be spin related [20, 21]. The $0.7\times G_0$ structure is more pronounced at 4.2 K [20] although the origin of the $0.7\times G_0$ anomaly is still unclear with explanations varying from ferromagnetic spin-coupling [22], to Wigner crystallisation [12] to the influence of inelastic scattering [23, 24].

B. Finite source drain voltage

Measurements were made at 50 mK with a D.C. source drain bias. This caused additional

plateaus to appear at half integer values $(N\pm 1/2)\times G_0$ [25, 26] where N is an integer. However, the half integer plateaus reported here are significantly clearer than in the earlier studies and requires no external magnetic field [26, 27]. To fully investigate this phenomenon D.C. bias spectroscopy was performed on the device, stepping the D.C. bias (V_{sd}) from 8 mV to -8 mV in 0.025 mV increments. This can be seen in figure 2. A clear feature of this D.C. bias spectroscopy is the fact that it is asymmetric between positive and negative bias. While positive D.C. source drain bias has a $0.5 \times G_0$ structure that stays strong with increasing D.C. source drain bias, there is a $0.25 \times G_0$ structure that develops at negative D.C. source drain bias. This asymmetry could be from self-consistent electrostatic effects close to channel pinch-off, or it could be caused by lateral spin-orbit coupling due to a small asymmetry in the confining potential. This asymmetric appearance of the $0.25 \times G_0$ could mean that a total spin polarisation is energetically unfavourable and a spin density wave or Skyrmion forms. Alternatively, a ferromagnetic ground state in an applied magnetic field with an interaction induced, spin-polarisation can be observed [28]. In GaAs devices under similar conditions a $0.25 \times G_0$ plateau usually forms rather than at $0.5 \times G_0$ and this has been explained as due to the source drain bias lifting the momentum degeneracy resulting in a unidirectional ferromagnetic order [29]. In this case a plateau appears at $0.5 \times G_0$ and stays with increasing D.C. source drain bias. There are anomalous plateaus in the conductance that show up at $0.8 \times G_0$ and $1.7 \times G_0$ in the conductance plot, see figure 2 (b). These behave in a similar way to the $0.7 \times G_0$ structure and are thought to be related to spin as a partially spin-polarized phase [30].

C. Applied magnetic fields

The magnetic field is applied in-plane and perpendicular to the effective Rashba field, i.e. along the 1-dimensional channel. This probes the low g-factor orientation and the effects of spin-orbit coupling should be clearer. 1-dimensional transport measurements [31] with an in-plane magnetic field show that in contrast to GaAs, only small magnetic fields are required to lift the spin degeneracy in InGaAs devices. Figure 3(a) shows a plot of the transconductance (dG/dV_{sg}) as the D.C. source drain bias is stepped from -8 mV to +8 mV in zero magnetic field. In figure 3(a) δV_g corresponds the difference in patterned gate voltage as the N = 2 and N = 1 subbands cross with finite V_{sd}. Figure 3(b) shows the

 Zeeman splitting in the transconductance (dG/dV_{sg}) from 0 T to 8 T with $V_{sd} = 0$ V. In figure 3(b) δV_g corresponds the difference in patterned gate voltage as the N = 2 and N = 1 subbands cross in a parallel magnetic field. In_{0.75}Ga_{0.25}As devices require ~ 1.5 T of parallel magnetic field (B_I) to lift the spin degeneracy compared with ~ 6 T for GaAs [31]. We obtain the g-factor using the technique developed in [26] which combines the measurement of the splitting due to the applied source drain bias with measurements where Zeeman splitting is due to the parallel magnetic field. The subband energy is measured by observing the splitting in gate voltage (δV_g) due to an applied D.C. source drain bias. The energy difference between spin-split energy levels is defined by the Zeeman energy (E_Z), see equation (1),

$$|\mathbf{g}^*| = \frac{1}{\mu_B} \frac{d\mathbf{E}_z}{dB_{||}} = \frac{1}{\mu_B} \frac{d\mathbf{E}_z}{dV_{sg}} \frac{d\mathbf{V}_{sg}}{dB_{||}} = \frac{\mathbf{e}}{\mu_B} \frac{d\mathbf{V}_{sg}}{dV_{sg}} \frac{d\mathbf{V}_{sg}}{dB_{||}}$$
(1)

e is the unit of charge. In figure 3(a), the subband spacing is shown to be between 3.6 meV and 2.5 meV. Larger values were reported in $In_{0.75}Ga_{0.25}As/InP$ [32]. However, these devices were fabricated from etched wires that require a perpendicular magnetic field in order to reduce the disorder in the system and achieve quantised conductance [27, 33]. The term dV_{sg}/dB_{\parallel} can be estimated from figure 3(b). We obtain an effective g-factor of 6.5 for the lowest subband N = 1, and the data is obtained in the absence of Landau quantisation using finite perpendicular magnetic field. Table 1 is a summary for the lowest 3 subbands.

In a 2DEG with Rashba-type spin-orbit coupling, the band structure is split into two parabola, with a linear shift in k (the in-plane wave vector) with energies, $E^{\pm}(k)$ given by equation (2),

$$\boldsymbol{E}^{\pm}(\boldsymbol{k}) = \frac{\hbar^2 \boldsymbol{k}^2}{2\boldsymbol{m}^*} \pm \alpha \boldsymbol{k}$$
(2)

where α is the Rashba parameter for this heterojunction system. In the In_{0.75}Ga_{0.25}As quantum well, the Rashba coefficient is 0.67×10^{11} eV.m with a spin-orbit splitting energy

of ~ 2.2 meV [8]. When this Rashba spin-orbit coupling is included in the calculation of the effective g-factor, this reduces the estimated value to 6 in the lowest subband (N = 1) for in-plane applied fields perpendicular to the Rashba field. The reduction in g-factor from the measured 2-dimensional value is due to the competition of Rashba and Zeeman magnetic fields. This reduction is one of the manifestations of the Rashba spin-orbit coupling effect that creates an effective magnetic field (~ 4 T), pinning the spin angular momentum in this in-plane direction [8].

D. Asymmetric patterned gate voltages

Asymmetric split-gate biasing was studied by stepping one patterned gate voltage and sweeping the second, see figure 4, where ΔV shows the difference in patterned gate voltage. We observe a weak spin-split $0.5 \times G_0$ plateau appearing, however this feature increases to $0.75 \times G_0$ as the channel is made more asymmetric. In addition there are plateaus which appear at $1.5 \times G_0$ and $3.5 \times G_0$ as the channel is made more asymmetric. The spin-split $0.5 \times G_0$ plateau has already been observed in an InAs quantum well with InGaAs barriers, when the confining potential was made asymmetric. This was ascribed to a lateral spin-orbit coupling effect [34]. However these measurements reported in reference [34] were made using etched channels with side gates. The etched wires have edges that are exposed to roughness and disorder and the spin-orbit length is smaller due to stronger confinement [35]. Spin-polarisation can be triggered by lateral spin-orbit coupling and lead to fully spin-polarised state in the presence of strong electron-electron interaction however this effect is not seen in these structures even though the measured Rashba spin-splitting energy is ~ 2.2 meV in this 2-dimensional system [8].

4. Conclusions

In_{0.75}Ga_{0.25}As patterned gate devices investigated in this paper show the effects of spinorbit interaction predominantly through a g-factor reduction rather than spin resolved conductance plateau at $0.5xG_0$ and higher conductance half plateaus. These experiments have determined the optimum device length scales to study quantised conductance with minimal effects from disorder and impurities that have plagued early studies of devices based on the InGaAs material system. These experiments have demonstrated that

In_{0.75}Ga_{0.25}As patterned gate devices are suitable for future spintronic devices that require only minimal applied magnetic fields. There is a reduction in backscattering due to spinorbit coupling at the 1-dimensional channel that leads to enhanced ballistic quantisation up to a conductance of $6 \times (2e^2/h)$ even with appreciable disorder present.

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References

[1] Žutić Igor, Fabian Jaroslav, and Das Sarma S 2004 Reviews of Modern Physics **76** 323

[2] Wang Chuan-Kui and Berggren K-F 1996 Phys. Rev. B 54 R14257

[3] Semiconductor Spintronics and Quantum Computation, edited by Awschalom D D, Loss D, and Samarth N 2002 Springer Berlin Germany

[4] Rashba E I 1960, Sov. Phys. Solid State 2 1109

[5] Bychkov Yu A and Rashba E I 1984 JETP Lett. 39 78

[6] Winkler R 2003 Spin-Orbit Coupling Effects in Two-Dimensional Electron and Hole Systems **191** Springer-Verlag, Berlin, Heidelberg

[7] Flindt Christian, Sørensen Anders S, and Flensberg Karsten 2006 Phys. Rev. Lett. 97

[8] Holmes S N, Simmonds P J, Beere H E, Sfigakis F, Farrer I, Ritchie D A, and Pepper M 2008 J. Phys.: Condens. Matter 20 472207

[9] Gozu Shin-ichirou, Hong Chulun and Yamada Syoji 1998 Jpn. J. Appl. Phys. 37 L1501

[10] Wharam D, Thornton T J, Newbury R, Pepper M, Ahmed H, Frost J, Hasko D, Peacock D, Ritchie D A, and Jones G A C 1988 J. Phys. C **21** L209

[11] Van Wees B J, Van Houten H, Beenakker C W J, Williamson J G, Kouwenhoven LP, van der Marel D, and Foxon C T 1988 Phys. Rev. Lett. 60 848

[12] Matveev K A 2004 Phys. Rev. B 70 245319

[13] Simmonds P J, Sfigakis F, Beere H E, Ritchie D A, Pepper M, Anderson D, and Jones G A C 2008 Appl. Phys. Lett. **92** 152108

1	
2 3	
5 4	[14] Simmonds P J, Holmes S N, Beere H E, Farrer I, Sfigakis F, Ritchie D A, Pepper M
5	2009 J. Vac. Sci. Technol. B27 2066
6	
7	
8	[15] Chen Chong, Farrer Ian, Holmes Stuart N, Sfigakis Francois, Fletcher Marc P, Beere
9	Harvey E, Ritchie David A 2015 J. Cryst. Growth 425 70
10	
11	
12 13	[16] Kajiyama K, Mizushima Y, and Sakata S 1973 Appl. Phys. Lett. 23 458
13 14	
15	[17] Lehmann H, Benter T, von Ahnen I, Jacob J, Matsuyama T, Merkt U, Kunze U,
16	
17	Wieck A D, Reuter D, Heyn C and HansenW 2014 Semicond. Sci. Technol. 29 075010
18	
19	[18] Smith L W, Al-Taie H, Sfigakis F, See P, Lesage A A J, Xu B, Griffiths J P, Beere
20	
21	H E, Jones G A C, Ritchie D A, Kelly M J, and Smith C G 2014 Phys. Rev. B 90 045426
22	
23	[19] Sasaki A, Nonaka S, Kunihashi Y, Kohda M, Bauernfeind T, Dollinger T, Richter K,
24 25	[17] Sasaki A, Nohaka S, Kuninasin T, Kohda M, Dadermend T, Doninger T, Kienter K,
26	and Nitta J 2014 Nat. Nanotechnol. 9 703
27	
28	[20] Thomas K J, Nicholls J T, Simmons M Y, Pepper M, Mace D R, and Ritchie D A
29	[20] Thomas K J, Menons J T, Simmons W T, Tepper W, Mace D K, and Kitchie D A
30	1996 Phys. Rev. Lett. 77 135
31	
32	[21] Reilly D J 2005 Phys. Rev. B 72 033309
33 34	
35	
36	[22] Aryanpour K and Han J E 2009 Phys. Rev. Lett. 102 056805
37	
38	[23] Sloggett C, Milstein A L, and Sushkov O P 2008 The European Physical Journal B
39	
40	61 427
41	
42 43	[24] Lunde A M, De Martino A, Schulz A, Egger R and Flensberg K 2009 New J. Phys.
43 44	
45	11 023031
46	
47	[25] Glazman L I and Khaetskii A V 1989 Europhys. Lett. 9 263
48	
49	[26] Detal N.K. Nishalla J.T. Martin Manna J. Daman M. Erect J.E.E. Ditable D.A. and
50	[26] Patel N K, Nicholls J T, Martin-Moreno L, Pepper M, Frost J E F, Ritchie D A, and
51 52	Jones G A C 1991 Phys. Rev. B 44 13549
52 53	
55 54	[27] von Wanaran Ilaa Dissard Schastian D. Dakkars Erik D. A. M. Eralay Saraay M. and
55	[27] van Weperen Ilse, Plissard Sébastien R, Bakkers Erik P A M, Frolov Sergey M, and
56	Kouwenhoven Leo. P 2013 Nano Lett. 13 387
57	
58	
59	11

[28] Renard V T, Piot B A, Waintal X, Fleury G, Cooper D, Niida Y, Tregurtha D, Fujiwara A, Hirayama Y, and Takashina K 2015 Nat. Commun. **6** 7230

[29] Chen T-M, Graham A C, Pepper M, Farrer I, and Ritchie D A 2008 Appl. Phys. Lett.93 032102

[30] Kristensen A, Bruus H, Hansen A E, Jensen J B, Lindelof P E, Marckmann C J, Nygård J, Sørensen C B, Beuscher F, Forchel A, and Michel M 2000 Phys. Rev. B **62**

[31] Pepper Michael and Bird Jonathan 2008 J. Phys.: Condens. Matter 20 160301

[32] Martin T P, Szorkovszky A, Micolich A P, Hamilton A R, Marlow C A, Linke H, Taylor R P, and Samuelson L 2008 Appl. Phys. Lett. **93** 012105

[33] Kohda M, Nakamura S, Nishihara Y, Kobayashi K, Ono T, Ohe J-i, Tokura Y, Mineno T, and Nitta J 2012 Nat. Commun. **3** 1082

[34] Debray P, Rahman S M S, Wan J, Newrock R S, Cahay M, Ngo A T, Ulloa S E, Herbert S T, Muhammad M, and Johnson M 2009 Nat. Nanotechnol. **4** 759

[35] Shabani J, Kim Younghyun, McFadden A P, Lutchyn R M, Nayak C, and Palmstrøm C J 2014 arXiv:1408.1122v1

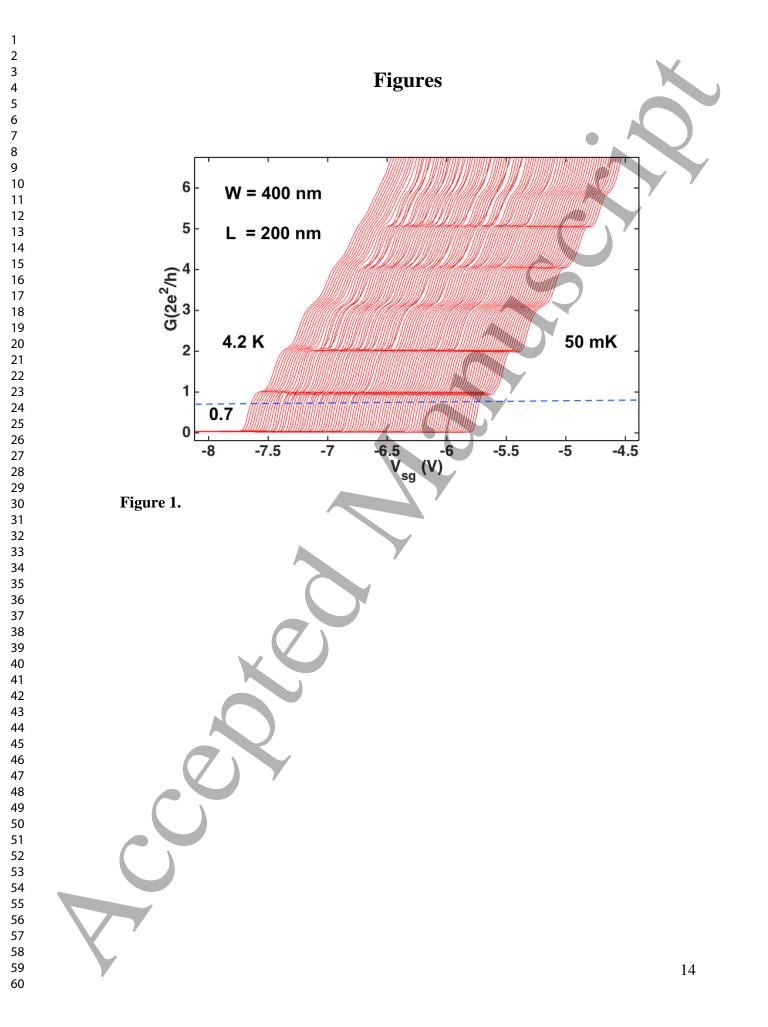
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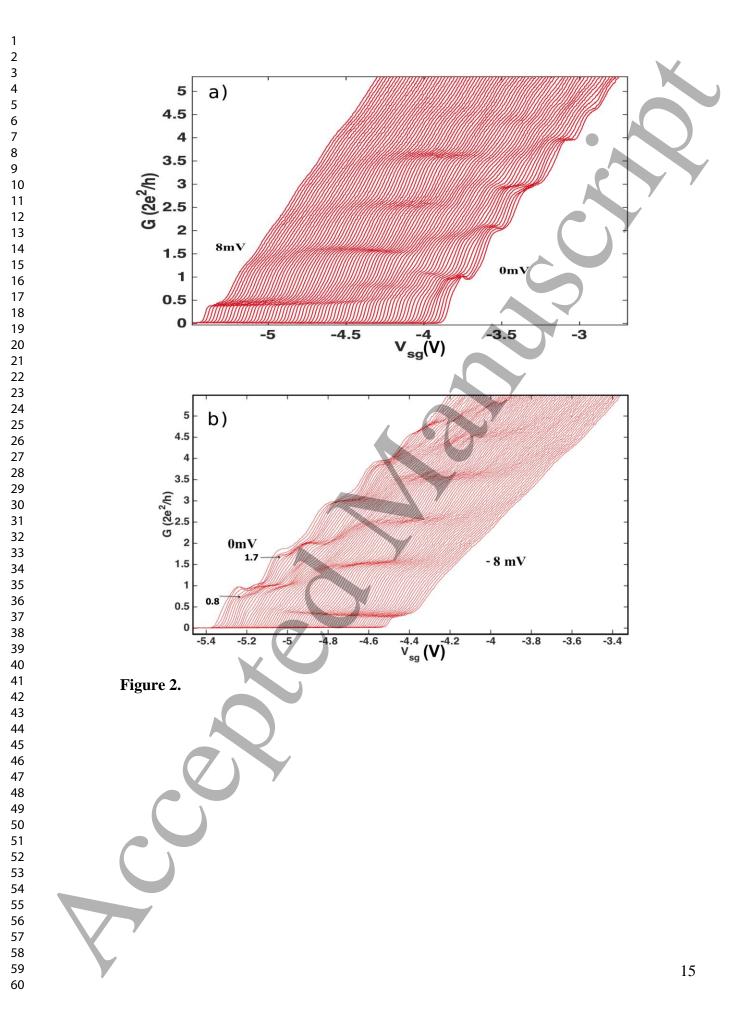
Figure 1 The differential conductance (G) in units of $2e^2/h$ as a function of patterned (split) gate voltage (V_{sg}) from 4.2 K to 50 mK in intervals of 0.05 K for the device with channel length 200 nm and patterned gate separation 400 nm. The conductance has been corrected for a series resistance and offset horizontally by 25 mV per set temperature. The dashed blue line indicates the $0.7 \times (2e^2/h)$ conductance feature.

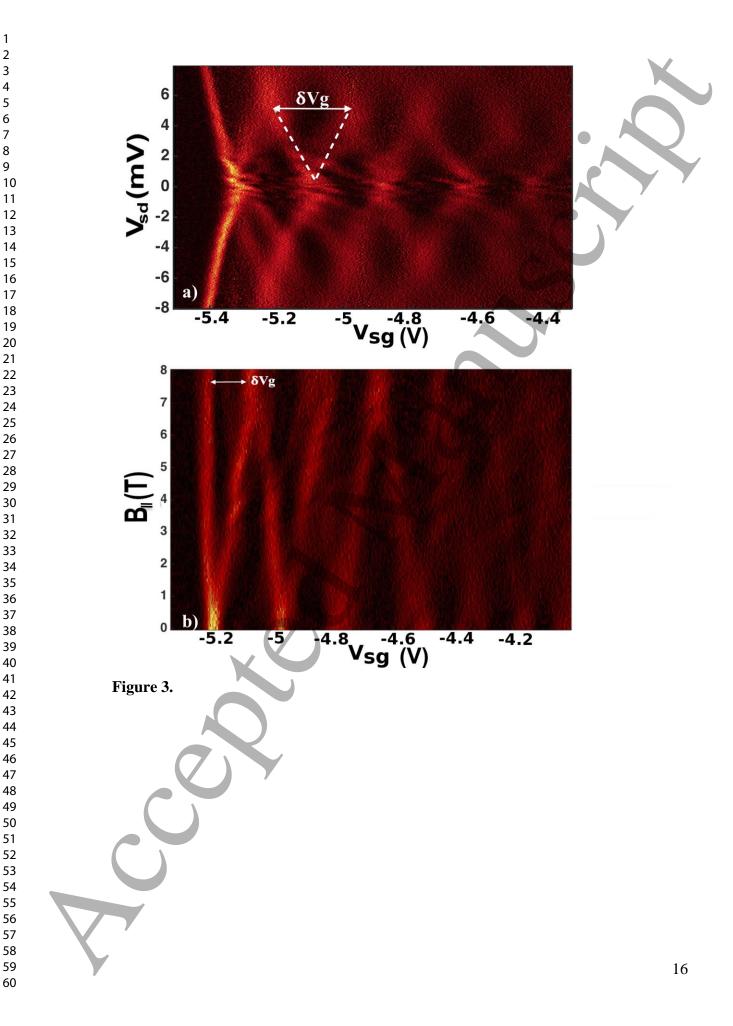
Figure 2(a) D.C. bias spectroscopy of the device from 0 mV to 8 mV. The $0.5\times(2e^2/h)$ conductance plateau is observed and remains from 3 mV with further plateaus developing at 1.5, 2.5 and $3.5\times(2e^2/h)$. (b) D.C. bias spectroscopy of the device from 0 mV to -8 mV. The $0.5\times(2e^2/h)$ is again observed at ~ 3 mV, but tends to shift below $0.5\times(2e^2/h)$ to $0.25\times(2e^2/h)$ as the D.C. bias is increased.

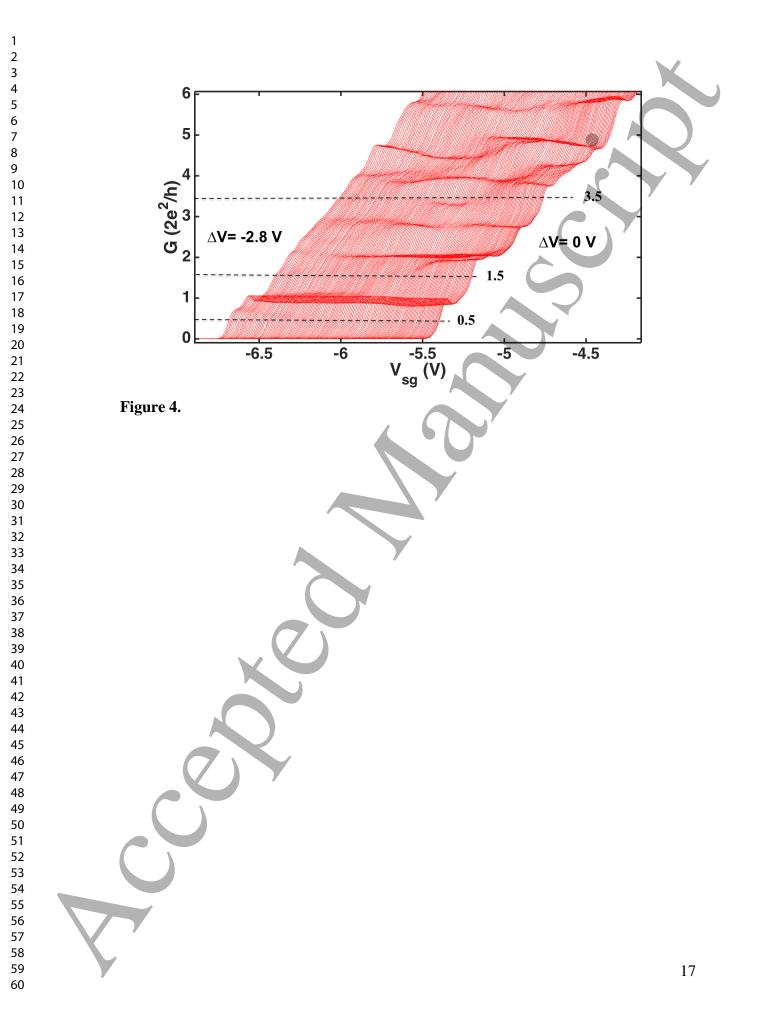
Figure 3(a) The Transconductance (dG/dV_{sg}) as a function of gate voltage (V_{sg}) plotted against D.C. source drain bias (V_{sd}) with parallel magnetic field (B_{\parallel}) set to 0. Regions of bright orange and red correspond to large amplitude dG/dV_{sg} , indicating the locations of subband transitions. (b) Transconductance (dG/dV_{sg}) as a function of gate voltage (V_{sg}) and parallel magnetic field (B_{\parallel}) . Regions of orange and red indicate large amplitude of dG/dV_{sg} corresponding to locations of subband transitions.

Figure 4 The device conductance as a function of asymmetric voltage to the patterned gates. One gate is held constant and the other gate is shifted incrementally up to $\Delta V = -2.8$ V at 50 mK in voltage steps of 20 mV.









Tables

subband	N=1	N=2	N=3
$\delta E_{n,n+1} (meV)$	3.8	2.9	2.5
$\delta V_g / \delta B_{\parallel} (V/T)$	0.016	0.021	0.022
$\delta eV_{sd}/\delta V_g \ (meV/V)$	23	17.1	12.8
g*	6.5	6.2	4.9

Table 1. Summary of the g-factors obtained for the first three sub-bands